Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,829	BEENAU ET AL.	
Examiner	Art Unit	
Nam V. Nguyen	2635	

SEARCHED				
Class	Subclass	Date	Examiner	
340	5.53	12/10/2005	NN	
340	5.2	12/10/2005	NN	
340	5.4+	12/10/2005	NN	
340	5.52	12/10/2005	NN	
340	5.6	12/10/2005	NN	
340	5.8+	12/10/2005	NN	
340	10.1	12/10/2005	NN	
340	10.4-10.5	12/10/2005	NN	
235	379	12/10/2005	NN	
235	380	12/10/2005	NN	
235	492	12/10/2005	NN	
705	35,54,76	12/10/2005	NN	
705	186,194	12/10/2005	NN	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Search East: USPAT; US-PUB; EPO;JPO and Derwent.	12/10/2005	NN 		
		, d 401 A174		
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